## **General Description**

The WSD80N10GDN56 is the highest performance trench N-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSD80N10GDN56 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

#### **Features**

- 100% UIS Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

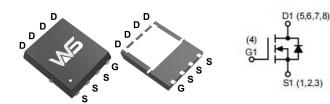
## **Product Summery**

BV <sub>DSS</sub>	$R_{DS(ON)}$	I <sub>D</sub>		
100V	6.7mΩ	80A		

## **Applications**

- Power Management for Industrial DC/DC Converters
- Ldeal for high-frequency switching and synchronous rectification

## **DFN5\*6-8L Pin Configuration**



# **Absolute Maximum Ratings** (T<sub>A</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter		Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage		100	.,	
V <sub>GS</sub>	Gate-Source Voltage		±20	V	
1 7	Continuous Drain Current	T <sub>C</sub> =25°C	80		
I <sub>D</sub> <sup>7</sup>	Continuous Drain Current	T <sub>C</sub> =100°C	56	Α	
I <sub>DM</sub> <sup>3</sup>	Pulse Drain Current		320		
P <sub>D</sub> <sup>2</sup>	Power Dissipation T <sub>C</sub> =25°C		111	W	
I <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Current		27	Α	
E <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Energy L=0.5mH		230	mJ	
T <sub>STG</sub>	Storage Temperature Range		-55 to 150	°C	
TJ	Operating Junction Temperature Range		-55 to 150		
D 14	Thermal Resistance-Junction to Ambient	t≤10s	30		
R <sub>θJA</sub> <sup>1,4</sup>	Steady State	Steady State	40	°C/W	
R <sub>θJC</sub>	Thermal Resistance-Junction to Case		1.1		

### **Electrical Characteristics** (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250μA	100			V
		V <sub>GS</sub> =10V , I <sub>D</sub> =20A		6.7	7.8	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	T <sub>J</sub> =125°C		9.1		mΩ
		$V_{GS}$ =4.5V , $I_{D}$ =20A		7.8	9.9	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_{D}=250\mu A$	1.2	1.7	2.5	V
	Drain-Source Leakage Current	V <sub>DS</sub> =80V , V <sub>GS</sub> =0V			1.0	
I <sub>DSS</sub>	Diani-Source Leakage Current	T <sub>J</sub> =55°C			5.0	5.0 µA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{DS}$ =0V , $V_{GS}$ =±20V			±100	nA
9 <sub>fs</sub>	Forward Transconductance	$V_{DS}$ =10V , $I_{D}$ =20A		20		S
$R_G$	Gate Resistance	f=1.0MHz	1.0	2.0	3.0	Ω
$Q_g$	Total Gate Charge (10V)			44		
$Q_{gs}$	Gate-Source Charge	$V_{DS}$ =50V , $V_{GS}$ =10V , $I_{D}$ =20A		9.5		nC
$Q_{gd}$	Gate-Drain Charge			7.8		
T <sub>d(on)</sub>	Turn-On Delay Time			11		
T <sub>r</sub>	Rise Time	$V_{DD}$ =50V , $V_{GS}$ =10V , $I_{D}$ =20A		10		no
$T_{d(off)}$	Turn-Off Delay Time	$R_{I}=1\Omega$ , $R_{GEN}=3\Omega$		34		ns
T <sub>f</sub>	Fall Time	32.1		46		
C <sub>iss</sub>	Input Capacitance			2600		
C <sub>oss</sub>	Output Capacitance	$V_{DS}$ =50V , $V_{GS}$ =0V , $f$ =1.0MHz		800		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			20		

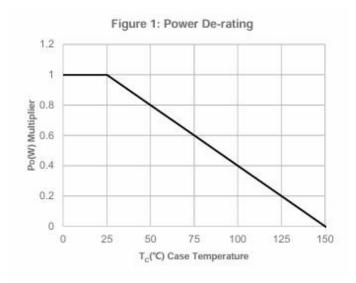
#### **Diode Characteristics**

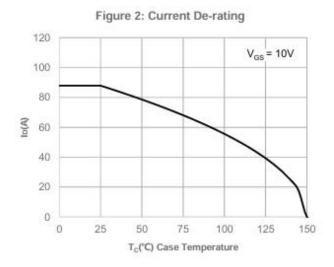
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I <sub>S</sub> <sup>7</sup>	Continuous Source Current				80	Α
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =1A		0.7	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>E</sub> =20A , di/dt=500A/µs		47		ns
Q <sub>rr</sub>	Reverse Recovery Charge	1 <sub>F</sub> -20A , αl/αι-300A/μs		50		nC

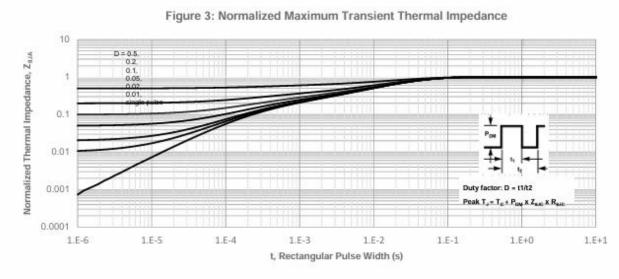
#### Note:

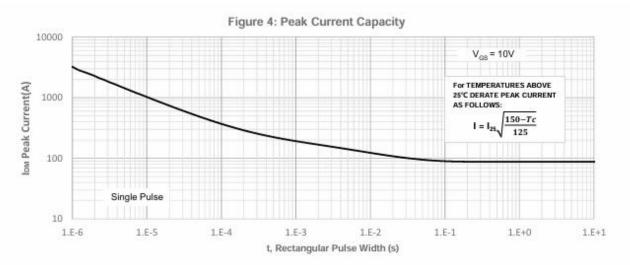
- 1. The value of R<sub>BJA</sub> is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>BJA</sub> t≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 2. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C.
- 4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- 5. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu s$  pulses, duty cycle 0.5% max.
- 6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.
- 7. The maximum current rating is package limited.
- 8. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.
- 9. The maximum current rating is silicon limited

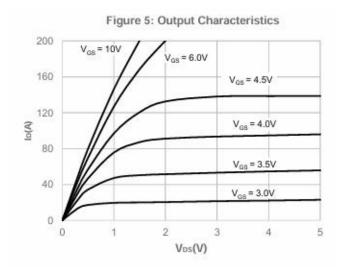
# **Typical Characteristics**

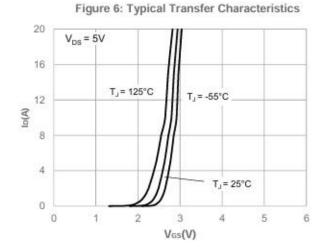


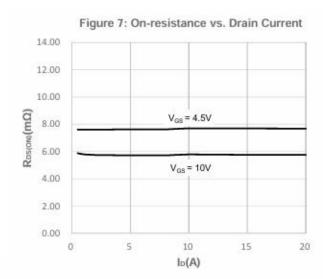


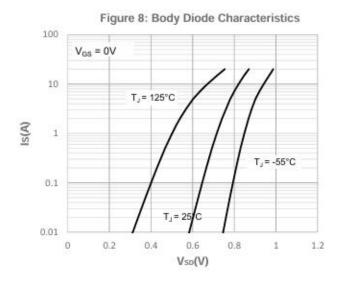


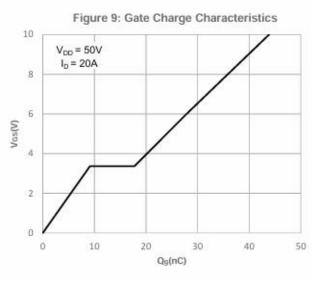












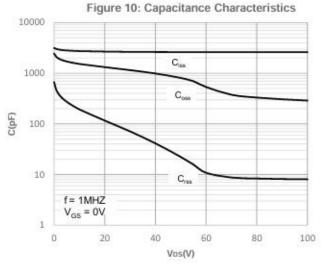


Figure 11: Normalized Breakdown voltage vs. Junction Temperature

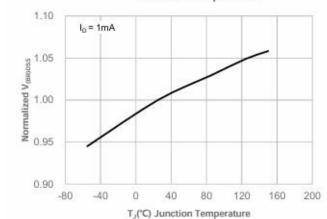


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

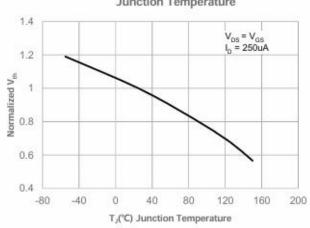


Figure 15: Maximum Safe Operating Area

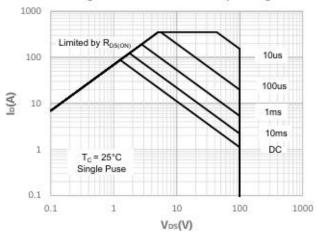
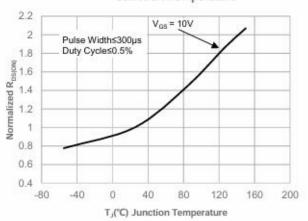
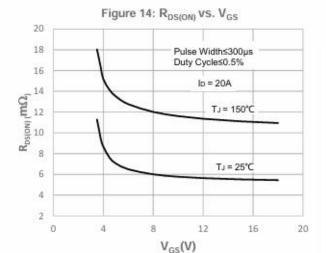
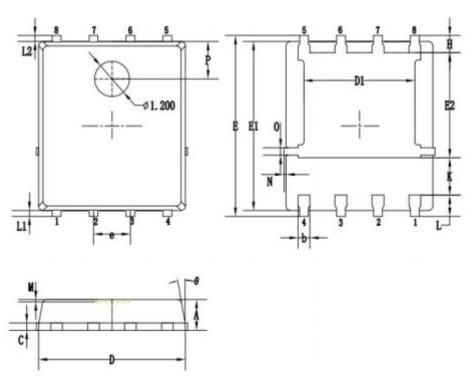


Figure 12: Normalized on Resistance vs. Junction Temperature





# **Packaging information**



SYMBOLS	MILLIMETERS			
	MIN.	NOM.	MAX.	
Α	0.90	1.05	1.20	
b	0.35	0.40	0.50	
С	0.20	0.25	0.35	
D	4.90	5.05	5.20	
D1	3.72	3.82	3.92	
E	6.00	6.15	6.30	
E1	5.60	5.75	5.90	
E2	3.47	3.57	3.67	
е	1.27 BSC.			
Н	0.48	0.58	0.68	
K	1.17	1.27	1.37	
L	0.64	0.74	0.84	
L1/L2	0.20 REF.			
θ	8°	10°	12°	
M	0.08 REF.			
N	0		0.15	
0	0.25 REF.			
P	1.28 REF.			



# **WSD80N10GDN56**

**N-Channel MOSFET** 

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